Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/086,268	CHANG ET AL.	
Examiner	Art Unit	
Steven HD Nguyen	2665	

SEARCHED					
Class	Subclass	Date	Examiner		
370	351-356, 401	2/1/2006	ST		
379	265.09				
	88.17				
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
See East search history	2/1/2006	ST	